

Search Notes

Application/Control No.

10/054,818

Examiner

Phu K. Nguyen

Applicant(s)/Patent under
Reexamination

FUKUI ET AL.

Art Unit

2628

SEARCHED

Class	Subclass	Date	Examiner
345	629-633	2/12/2008	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST search - mobile service, effect area, service space, location, acquisition, shape, restrict, constraint, limit, identify	2/12/2008	PN
IEEE, ACM search - mobile service, service, space, area, location, acquisition, shape, restrict, constraint, limit, identify	2/12/2008	PN
Inventor Name search	2/12/2008	PN